

FCC TEST REPORT

For

Azlan Logistics Limited
Digital Amplifier
Model No.: AV-1800

Prepared For : Azlan Logistics Limited

Address : Redwood 2, Chineham Business Park, Crockford Lane, Basingstoke,

Hampshire, RG24 8WQ, United Kingdom

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Code:AB-RF-05-a



TEST REPORT

Applicant : Azlan Logistics Limited

Manufacturer : Azlan Logistics Limited

Product Name : Digital Amplifier

Model No. : AV-1800

Trade Mark : VISION

Rating(s) : Input: AC 100-240V, 50/60Hz, 1A Max

Test Standard(s) : FCC Part15 Subpart C 2017, Section 15.247

Test Method(s) : ANSI C63.10: 2013

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Prepared by

(Engineer / Oliay Yang)

Reviewer

(Supervisor / Calvin Liu)

Approved & Authorized Signer

(Manager / Tom Chen)



1. General Information

1.1. Client Information

Applicant	:	Azlan Logistics Limited
Address	:	Redwood 2, Chineham Business Park, Crockford Lane, Basingstoke, Hampshire, RG24 8WQ, United Kingdom
Manufacturer	:	Shenzhen Junlan Electronic Ltd
Address	:	Redwood 2, Chineham Business Park, Crockford Lane, Basingstoke, Hampshire, RG24 8WQ, United Kingdom

1.2. Description of Device (EUT)

Product Name	:	Digital Amplifier	hotek Anbotek Anbo tek Abotek
Model No.	:	AV-1800	And hotek Anbotek Anbot Anbot
Trade Mark	:	VISION	Am abotek Anbotek Anbo atek An
Test Power Supply	:	AC 240V, 60Hz/ AC 120V, 60Hz	Anbotek Anbotek Anb
		Operation Frequency:	2402MHz~2480MHz
		Transfer Rate:	1/2/3 Mbits/s
Product		Number of Channel:	79 Channels
Description	-	Modulation Type:	GFSK, π/4-DQPSK, 8-DPSK
		Antenna Type:	Cylindrical Antenna
		Antenna Gain(Peak):	3 dBi Anbotek Anbotek Anbo

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

2)This report is for BDR&EDR.

1.3. Auxiliary Equipment Used During Test

Mobile Phone	:	Manufacturer: HUAWEI
		M/N: C8650 S/N: L6W7NA11B1013157
		CE, FCC, DOC
DVD	:	Manufacturer: SONY
		M/N: BDP-S380 S/N: 4065848 CE , FCC



1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	CH00 Anbores Anbores Anbores
Mode 2	CH39
Mode 3	CH78
Mode 4	Keeping TX+ Charging Mode

	For Conducted Emission
Final Test Mode	Description
Mode 4	Keeping TX+ Charging Mode

For Radiated Emission							
Final Test Mode	Description						
Mode 1	K hotek Anbote CH00 And tek hotek A						
Mode 2	CH39 And Karek						
Mode 3	CH78 And						
Mode 4	Keeping TX+ Charging Mode						

Note:

- (1) The measurements are performed at the highest, middle, lowest available channels.
 - (2) The data rate was set in 1Mbps for radiated emission due to the highest RF output power.



1.5. List of channels

Channel	Freq.	Channel	Freq.	Channel	Freq.	Channel	Freq.	Channel	Freq.
	(MHz)		(MHz)		(MHz)		(MHz)		(MHz)
00	2402	An 17	2419	34	2436	51	2453	68	2470
01	2403	18	2420	35	2437	52	2454	69	2471
02	2404	19	2421	36	2438	53	2455	70	2472
03	2405	20	2422	37	2439	54	2456	71	2473
04	2406	21	2423	38	2440	55	2457	72	2474
05	2407	22	2424	39	2441	56	2458	73	2475
05	2408	23	2425	40	2442	57	2459	74	2476
⁶ 07	2409	24	2426	41 Anto	2443	58	2460	75	2477
08	2410	25	2427	42	2444	59	2461	76	2478
09	2411	26	2428	43	2445	60	2462	ote ^K 77	2479
10 ×	2412	27	2429	44	2446	61.000	2463	78	2480
phPore.	2413	28	2430	45	2447	62	2464	ATTV JOK	10010
12	2414	29	2431	46	2448	63	2465		
13	2415	30	2432	47	2449	64	2466		
14	2416	31	2433	48	2450	65	2467	V ab	
15 15	2417	32	2434	49	2451	66	2468		
16	2418	33	2435	50	2452	67	2469	0	

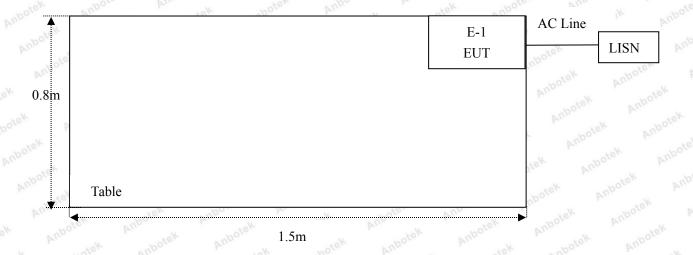
Note:

- 1. The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode.
- 2. EUT built-in battery-powered, fully-charged battery use of the test battery.

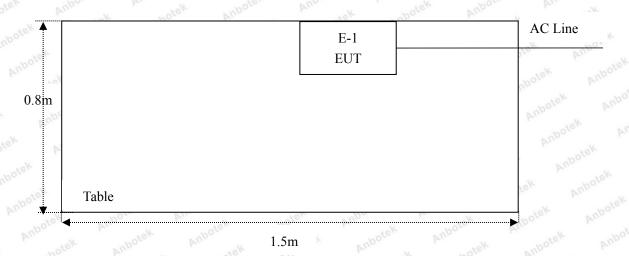


1.6. Description Of Test Setup

CE



RE





1.7. Test Equipment List

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
o ^{tek} 1.	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Nov. 17, 2017	1 Year
2.00	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year
3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Nov. 17, 2017	1 Year
4.	Spectrum Analysis	Agilent	E4407B	US39390582	Nov. 17, 2017	1 Year
5.	Spectrum Analysis	Agilent	N9038A	MY53227295	Nov. 17, 2017	1 Year
6.	Preamplifier	SKET Electronic	BK1G18G30D	KD17503	Nov. 17, 2017	1 Year
17.00	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year
8.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 20, 2017	1 Year
9.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Nov. 20, 2017	1 Year
10.	Loop Antenna	Schwarzbeck	HFH2-Z2	100047	Nov. 17, 2017	1 Year
Mi.	Horn Antenna	Schewarzbeck	BBHA9170	9170-375	Nov. 17, 2017	1 Year
12.	Pre-amplifier	SONOMA	310N	186860	Nov. 17, 2017	1 Year
13.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
14.	RF Test Control System	YIHENG	YH3000	2017430	Nov. 18, 2017	1 Year
15.	Power Sensor	DAER	RPR3006W	15I00041SN045	Nov. 17, 2017	1 Year
16.	Power Sensor	DAER	RPR3006W	15I00041SN046	Nov. 17, 2017	1 Year
17.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Nov. 18, 2017	1 Year
18.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Nov. 18, 2017	1 Year
19.	Signal Generator	Agilent	E4421B	MY41000743	Nov. 18, 2017	1 Year
20.	DC Power Supply	Ambote LW Ambot	TPR-6410D	349315	Nov. 01, 2017	1 Year
21.	Constant Temperature Humidity Chamber	Sertep	ZJ-HWHS80B	ZJ-17042804	Nov. 01, 2017	1 Year



1.7. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, July 31, 2017.

ISED-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A-1, June 13, 2016.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

at 1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102



2. Summary of Test Results

Test Item	Result
Antenna Requirement	PASS
Conducted Emission	PASS
Spurious Emission	PASS
Conducted Peak Output Power	PASS
20dB Occupied Bandwidth	PASS
Carrier Frequencies Separation	PASS
Hopping Channel Number	PASS
Dwell Time	PASS
Band Edge	PASS
	Antenna Requirement Conducted Emission Spurious Emission Conducted Peak Output Power 20dB Occupied Bandwidth Carrier Frequencies Separation Hopping Channel Number Dwell Time



3. Conducted Emission Test

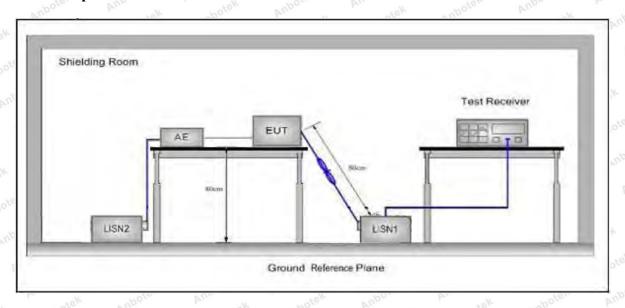
3.1. Test Standard and Limit

Test Standard	FCC Part15 Section 15.20	07 Anbote Amb	Anbotek Anbo tek				
	F	Maximum RF Line Voltage (dBuV)					
	Frequency	Quasi-peak Level	Average Level				
Test Limit	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *				
4	500kHz~5MHz	Anbotek 56 bot sek	46				
	5MHz~30MHz	60	50				

Remark: (1) *Decreasing linearly with logarithm of the frequency.

(2) The lower limit shall apply at the transition frequency.

3.2. Test Setup



3.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10-2013 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

3.4. Test Data

Please to see the following pages



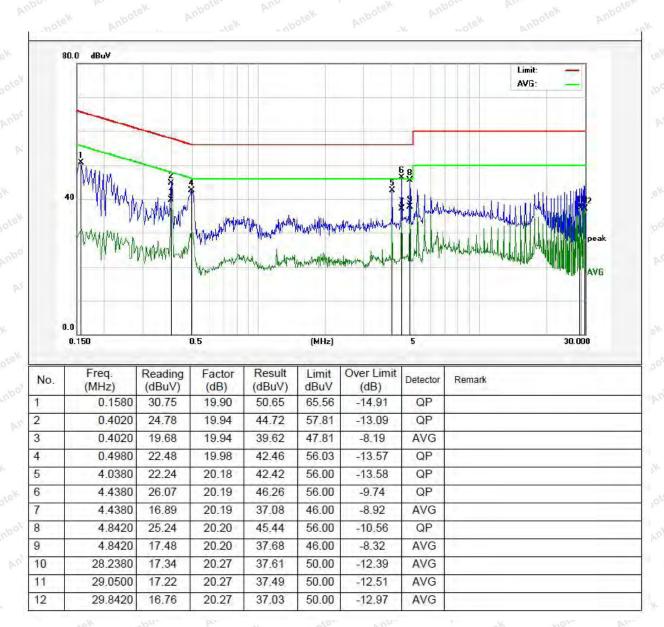
Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode

Test Specification: AC 240V, 60Hz

Comment: Live Line

Tem.: 22.2℃ Hum.: 60%





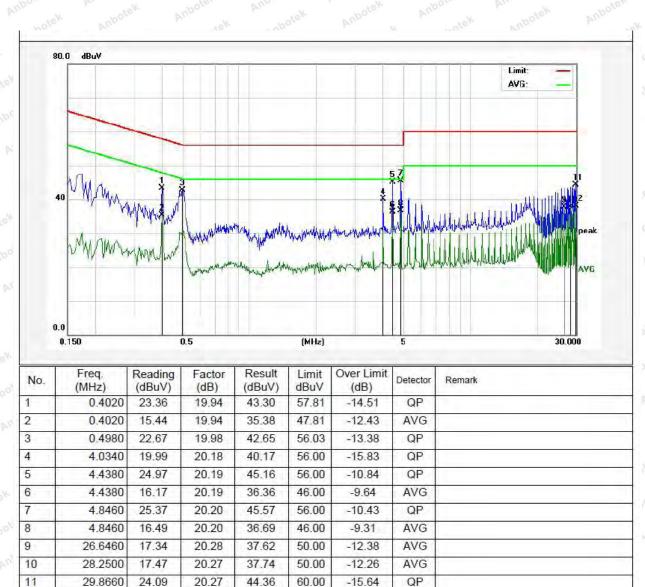
Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode

Test Specification: AC 240V, 60Hz

Comment: Neutral Line

Tem.: 22.2°C Hum.: 60%



20.27

12

29.8660

17.92

38.19

50.00

-11.81

AVG



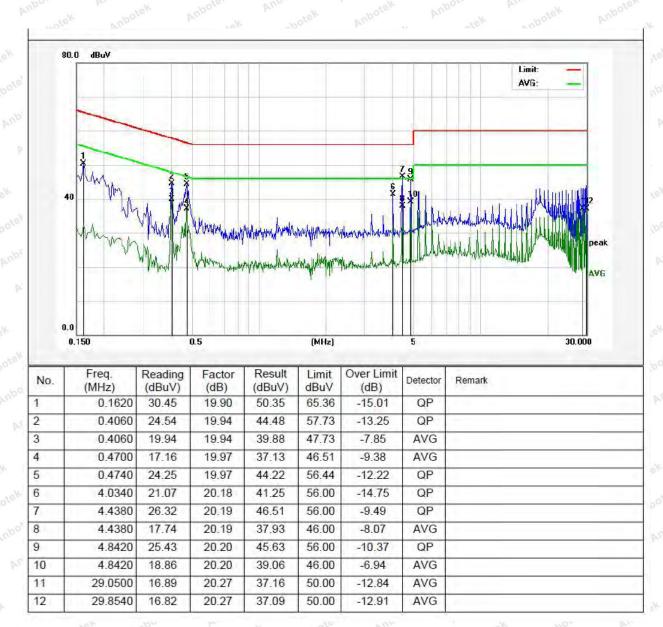
Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode

Test Specification: AC 120V, 60Hz

Comment: Live Line

Tem.: 22.2℃ Hum.: 60%





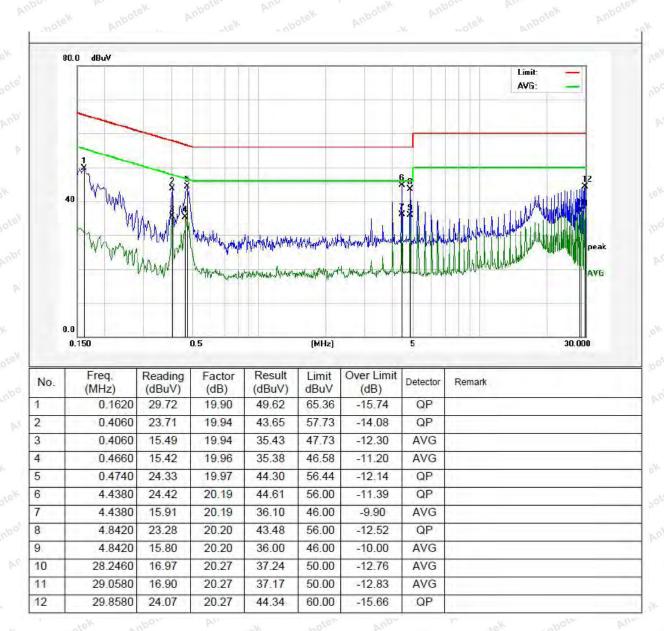
Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode

Test Specification: AC 120V, 60Hz

Comment: Neutral Line

Tem.: 22.2°C Hum.: 60%





4. Radiation Spurious Emission and Band Edge

4.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.20	09 and 15.205	Anhotek	Anbotek	upo. Yek
	Frequency (MHz)	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
	0.009MHz~0.490MHz	2400/F(kHz)	tek Anbor	ek abote	300
	0.490MHz-1.705MHz	24000/F(kHz)	nbotek Anbo	rek wh	30
	1.705MHz-30MHz	30	Anbotek A	lpo stek	nbotek 30 Anbr
Test Limit	30MHz~88MHz	100	40.0	Quasi-peak	Anbote3 A
	88MHz~216MHz	150	43.5	Quasi-peak	3.ek
	216MHz~960MHz	200	46.0	Quasi-peak	3,0016
	960MHz~1000MHz	500	54.0	Quasi-peak	tek 3 Anbotek
	Alexa 1000MII-	500	54.0	Average	botek 3 Anbo
	Above 1000MHz	eek And	74.0	Peak	Anbotel3 A

Remark:

- (1)The lower limit shall apply at the transition frequency.
- (2) 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

4.2. Test Setup

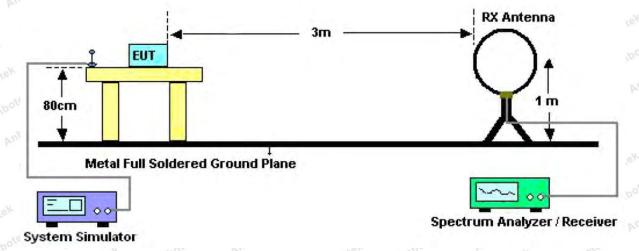


Figure 1. Below 30MHz

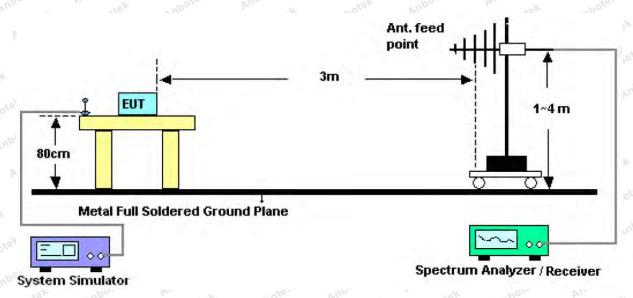


Figure 2. 30MHz to 1GHz

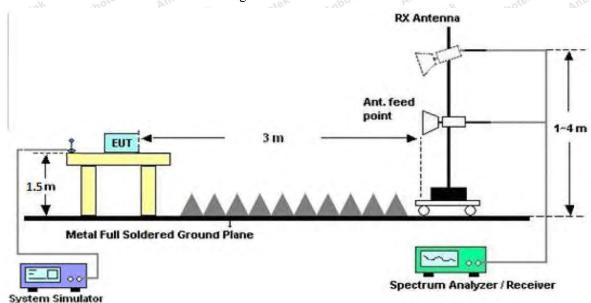


Figure 3. Above 1 GHz

4.3. Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. The device is evaluated in xyz orientation.

For the radiated emission test above 1GHz:

Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying



aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW = 1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as:

RBW = 9KHz, VBW = 30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as:

RBW = 100kHz, VBW =300kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For above 1GHz, Set the spectrum analyzer as:

RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple.

RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

4.4. Test Data

PASS

During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation which is worse case

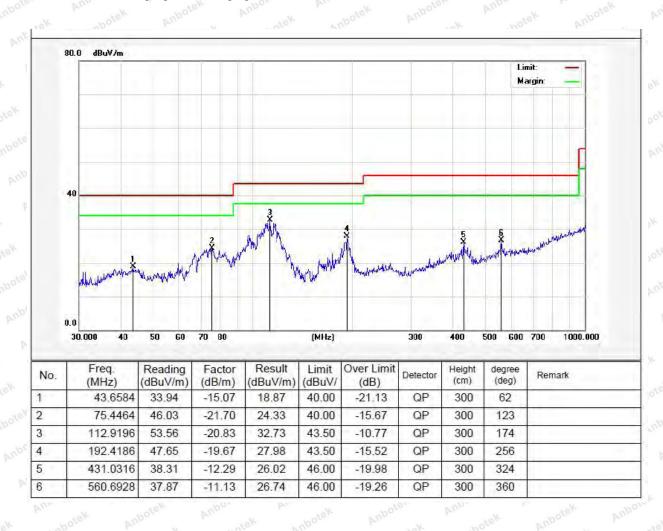
The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.



Job No.: R0217100052W1 Temp.(°C)/Hum.(%RH): 23.2°C/53.4%RH

Standard: FCC PART 15C Power Source: AC 240V, 60Hz

Test Mode: Keeping TX+ Charging Mode Polarization: Horizontal

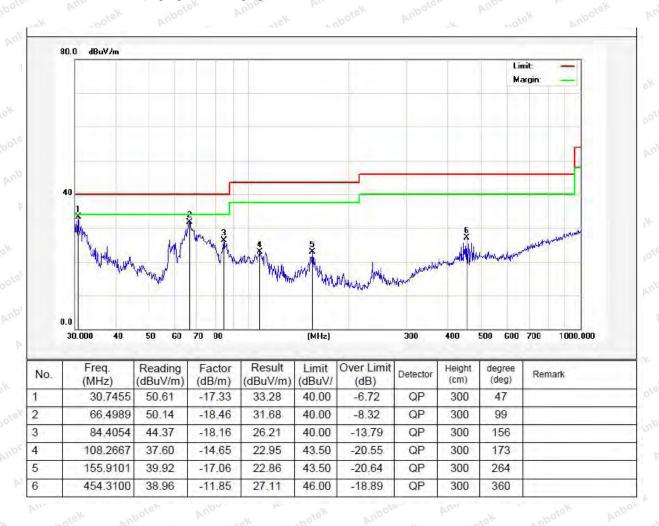




Job No.: R0217100052W1 Temp.(°C)/Hum.(%RH): 23.2°C/53.4%RH

Standard: FCC PART 15C Power Source: AC 240V, 60Hz

Test Mode: Keeping TX+ Charging Mode Polarization: Vertical

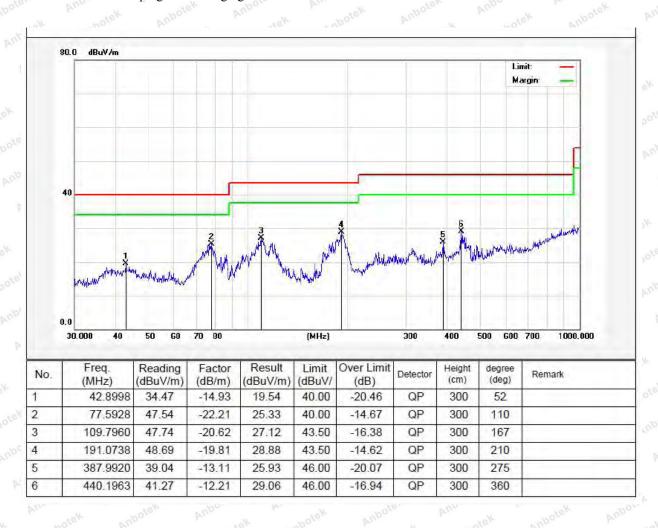




Job No.: R0217100052W1 Temp.(°C)/Hum.(%RH): 23.2°C/53.4%RH

Standard: FCC PART 15C Power Source: AC 120V, 60Hz

Test Mode: Keeping TX+ Charging Mode Polarization: Horizontal

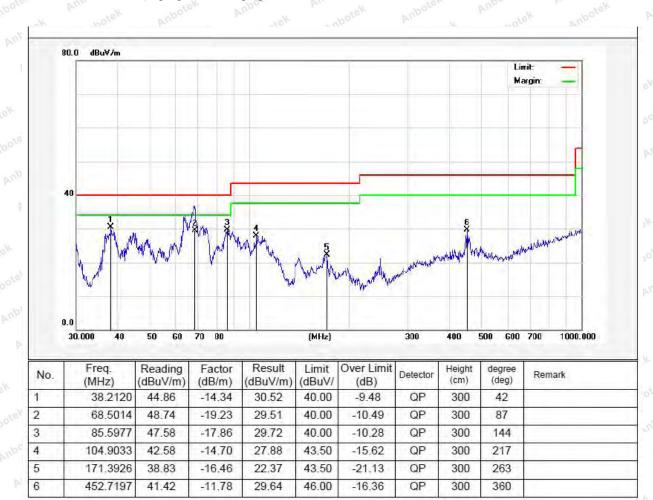




Job No.: R0217100052W1 Temp.(°C)/Hum.(%RH): 23.2°C/53.4%RH

Standard: FCC PART 15C Power Source: AC 120V, 60Hz

Test Mode: Keeping TX+ Charging Mode Polarization: Vertical





Test Results (1GHz-25GHz)

Test Mode: 0	CH00			Test	channel: Lowe	st		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	36.44	34.04	6.58	34.09	42.97	74.00	-31.03	boteV
7206.00	31.26	37.11	7.73	34.50	41.60	74.00	-32.40	No Ve
9608.00	30.96	39.31	9.23	34.79	44.71	74.00	-29.29	V
12010.00	*	stek v	botek p	upor	Viv.	74.00	Aupo	V
14412.00	* Anti	Nek	nbotek	Anbotek	Yun Potek	74.00	Anbos	v V
4804.00	40.55	34.04	6.58	34.09	47.08	74.00	-26.92	Н
7206.00	32.94	37.11	7.73	34.50	43.28	74.00	-30.72	H
9608.00	30.30	39.31	9.23	34.79	44.05	74.00	-29.95	Auport H
12010.00	* Anbote	Aupe	rek V	botek	Anbotek	74.00	anbotek	PH ^b
14412.00	kek * Anbo	rek by	Por b	"polek	Anborek	74.00	Napotek	Н
		**	A	verage Valu	e	W.V.	10.	
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	25.42	34.04	6.58	34.09	31.95	54.00	-22.05	V
7206.00	20.04	37.11	7.73	34.50	30.38	54.00	-23.62	V
9608.00	19.17	39.31	9.23	34.79	32.92	54.00	-21.08	V
12010.00	potek * A	/por	Anbotek .	Anbotes	Anbo	54.00	Anbo	V
14412.00	Anbotek	Anbore	An botek	Anboli	Amb	54.00	rek Au	V
4804.00	29.55	34.04	6.58	34.09	36.08	54.00	-17.92	Aupore.
7206.00	22.16	37.11	7.73	34.50	32.50	54.00	-21.50	ÞΉ
9608.00	18.83	39.31	9.23	34.79	32.58	54.00	-21.42	H
12010.00	dek *	potek	Aupore	Andrek	Anbotek	54.00	An.	Н
14412.00	*	abotek	Anbote	Ann	k knbote	54.00	ok h	ote ^K H



Test Results (1GHz-25GHz)

Test Mode: 0	CH39			Test	channel: Midd	le		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	36.10	34.38	6.69	34.09	43.08	74.00	-30.92	boteV
7323.00	31.03	37.22	7.78	34.53	41.50	74.00	-32.50	nbVel
9764.00	30.76	39.46	9.35	34.80	44.77	74.00	-29.23	V
12205.00	*	stek v	abotek p	upote	An.	74.00	Aupo	V
14646.00	* Anti	Yek	nbotek	Anboten	Yun Potek	74.00	Anbos	v V
4882.00	40.14	34.38	6.69	34.09	47.12	74.00	-26.88	Н
7323.00	32.68	37.22	7.78	34.53	43.15	74.00	-30.85	H
9764.00	30.07	39.46	9.35	34.80	44.08	74.00	-29.92	Anboto H
12205.00	* Anbote	Aupe	rek V	botek	Anbotek	74.00	Anbotek	PĤ
14646.00	kek * Anbo	rek by	Por b	abolek	Anboren	74.00	Anbotek	HN
30		**	A	verage Valu	e	W.V.		
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	25.15	34.38	6.69	34.09	32.13	54.00	-21.87	V
7323.00	19.86	37.22	7.78	34.53	30.33	54.00	-23.67	V
9764.00	19.01	39.46	9.35	34.80	33.02	54.00	-20.98	V
12205.00	potek * A	/por	h. nbotek	Anbores	Anbo	54.00	Anbo	V
14646.00	Anbotek	Aupor	A. botek	Anbott	Anbo	54.00	rek An	V
4882.00	29.25	34.38	6.69	34.09	36.23	54.00	-17.77	Anboten
7323.00	21.95	37.22	7.78	34.53	32.42	54.00	-21.58	ÞΉ
9764.00	18.64	39.46	9.35	34.80	32.65	54.00	-21.35	H
12205.00	dek *	potek	Aupore. K	And	Anbotek	54.00	A.V.	Н Ж
14646.00	*	botek	Anboten	Vun.	k hote	54.00	Pr.	o ^{tek} H



Test Results (1GHz-25GHz)

Test Mode: 0	CH78			Test	channel: Highe	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	36.19	34.72	6.79	34.09	43.61	74.00	-30.39	Voote
7440.00	31.09	37.34	7.82	34.57	41.68	74.00	-32.32	Nap Vel
9920.00	30.81	39.62	9.46	34.81	45.08	74.00	-28.92	V
12400.00	*	stek .	hotek p	upote	P.u.	74.00	Vupo.	V
14880.00	* And	Yel	nbotek	Anboten	Au, Polek	74.00	Anbot	V
4960.00	40.25	34.72	6.79	34.09	47.67	74.00	-26.33	Н
7440.00	32.75	37.34	7.82	34.57	43.34	74.00	-30.66	H
9920.00	30.13	39.62	9.46	34.81	44.40	74.00	-29.60	Aupore
12400.00	*nbote	Anbo	18K	botek	Anbotek	74.00	Anbotek	Ĥ
14880.00	ek * Anb	year by	loor b	potek	Anboren	74.00	Anbotek	HN
		**	A	verage Valu	e		-	
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	25.27	34.72	6.79	34.09	32.69	54.00	-21.31	V
7440.00	19.94	37.34	7.82	34.57	30.53	54.00	-23.47	V
9920.00	19.08	39.62	9.46	34.81	33.35	54.00	-20.65	V
12400.00	ootel * N	lpo.	P. Potek	Anboter	Anba	54.00	Aupo,	V
14880.00	Anbotek	Anbore	An botek	Anboli	Amb	54.00	tek An	V
4960.00	29.38	34.72	6.79	34.09	36.80	54.00	-17.20	Anbote.
7440.00	22.04	37.34	7.82	34.57	32.63	54.00	-21.37	ÞĤ
9920.00	18.72	39.62	9.46	34.81	32.99	54.00	-21.01	Но
12400.00	*	potek	Aupote	Anotek	Anbotek	54.00	A. Jook	Н Ж
14880.00	*	botek	Aupote.	Vun.	k abote	54.00	Pr.	ote ^K H

Remark:

- 1. During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor
- 3. "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.



Radiated Band Edge:

Test Mode: 0	CH00			Test	Test channel: Lowest				
				Peak Value					
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.	
2390.00	45.62	29.15	3.41	34.01	44.17	74.00	-29.83	Hek	
2400.00	62.80	29.16	3.43	34.01	61.38	74.00	-12.62	H	
2390.00	46.43	29.15	3.41	34.01	44.98	74.00	-29.02	V	
2400.00	65.13	29.16	3.43	34.01	63.71	74.00	-10.29	V	
			A	verage Valu	ie				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.	
2390.00	35.55	29.15	3.41	34.01	34.10	54.00	-19.90	Hoote	
2400.00	46.95	29.16	3.43	34.01	45.53	54.00	-8.47	HANK	
2390.00	35.69	29.15	3.41	34.01	34.24	54.00	-19.76	o [₩] V	
2400.00	48.86	29.16	3.43	34.01	47.44	54.00	-6.56	otelV	

Test Mode: CH78 Test channel: Highest								
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2483.50	48.05	29.28	3.53	34.03	46.83	74.00	-27.17	"Hk
2500.00	46.70	29.30	3.56	34.03	45.53	74.00	-28.47	Hot
2483.50	49.35	29.28	3.53	34.03	48.13	74.00	-25.87	V
2500.00	47.96	29.30	3.56	34.03	46.79	74.00	-27.21	V
			A	verage Valu	e	1837		
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2483.50	38.41	29.28	3.53	34.03	37.19	54.00	-16.81	A/Hote
2500.00	36.02	29.30	3.56	34.03	34.85	54.00	-19.15	Har
2483.50	39.85	29.28	3.53	34.03	38.63	54.00	-15.37	· V
2500.00	36.17	29.30	3.56	34.03	35.00	54.00	-19.00	tek V

Remark:

- 1. During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level = Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor

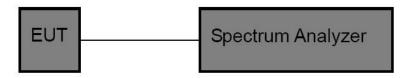


5. Maximum Peak Output Power Test

5.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.2	247 (b)(3)	Ann	Anbotek	Anbore	VI.
Test Limit	1W or 125 mW	Anbote.	Anv	Anbotek	Anbor	7

5.2. Test Setup



5.3. Test Procedure

- 1. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram above,
- 2. Spectrum Setting:

RBW > the 20 dB bandwidth of the emission being measured

PASS

Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel

 $VBW \ge RBW$

Sweep = auto

Detector function = peak

Trace = \max hold

5.4. Test Data

Test Result

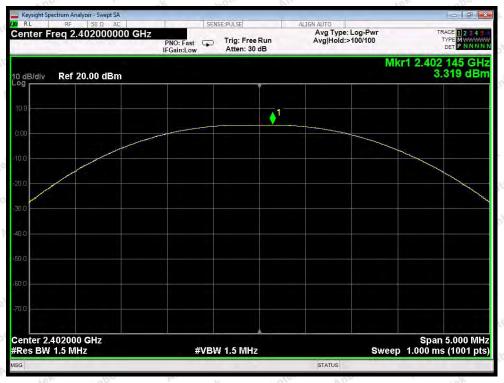
Test Item	:	Max. peak output power	Test Mode	:	CH Low ~ CH High
Test Voltage	:	AC 120V, 60Hz	Temperature	:	24°C

Humidity

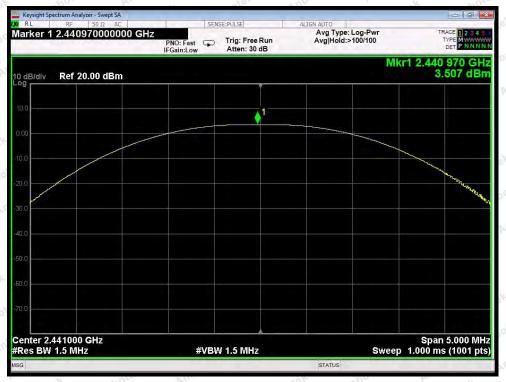
55%RH

Channel Frequency (MHz)	Peak Power output (dBm)	Limit (dBm)	Results	Modulation
2402	3.319	30	PASS	BDR
2441	3.507	30	PASS	BDR
2480	3.331	30	PASS	BDR
2402	1.899	20.96	PASS	EDR
2441	2.151 Anbotek	20.96	PASS	EDR
2480	2.128	20.96	PASS	EDR

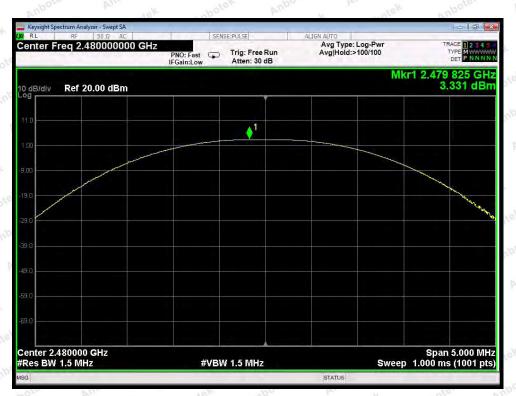




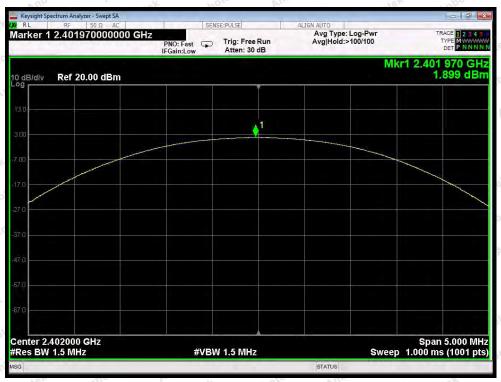
Test Mode: BDR---Low



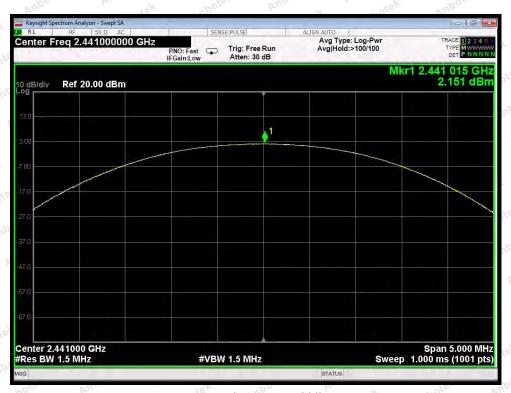
Test Mode: BDR---Middle



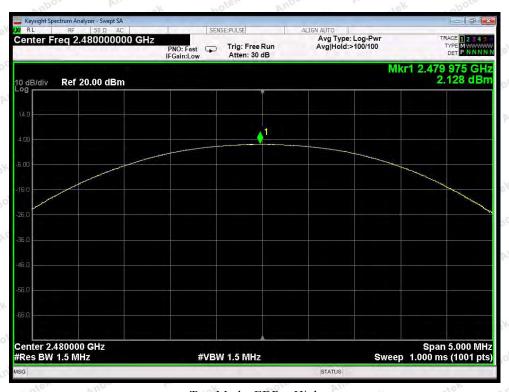
Test Mode: BDR---High



Test Mode: EDR---Low



Test Mode: EDR---Middle



Test Mode: EDR---High

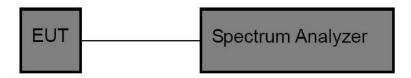


6. 20DB Occupy Bandwidth Test

6.1. Test Standard

Test Standard	FCC Part15 C Section 15.247 (a)(1)	Ann	Anbotek	Anbo	p.
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6.2. Test Setup



6.3. Test Procedure

Using the following spectrum analyzer settings:

- 1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

6.4. Test Data

Test Item : 20dB BW Test Mode : CH Low ~ CH High

Test Voltage : AC 120V, 60Hz Temperature : 24°C

Test Result : PASS Humidity : 55%RH

Channel	Frequency(MHz)	20dB Down BW(kHz)	Modulation Mode
Low	2402	928.0	BDR
Middle	2441	881.5	BDR
High Anbo	2480	929.7	BDR Amb
Low	2402	1461.0	EDR
Middle	2441	1450.0	EDR
High	2480	1480.0	EDR

Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of (8DPSK) is attached in the following pages.



Test Mode: BDR---Low

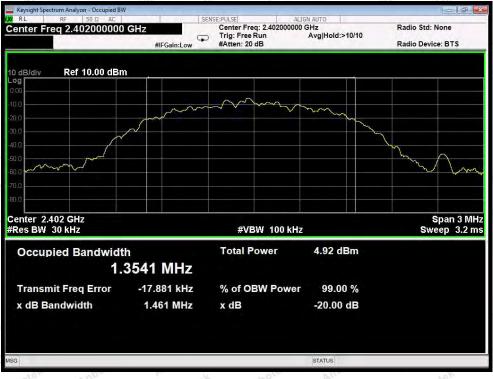


Test Mode: BDR---Middle





Test Mode: BDR---High

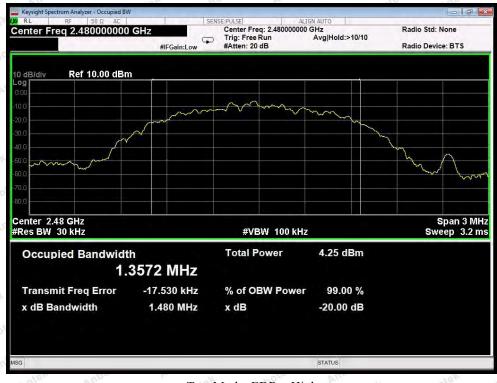


Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High

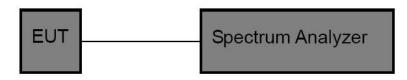


7. Carrier Frequency Separation Test

7.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (a)(1)	Anbotek	Anbo stek
Test Limit	>25KHz or >two-thirds of the 20 dB bandwidth	Anbotek	Anbo

7.2. Test Setup



7.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

- 1. Span= Wide enough to capture the peaks of two adjacent channels
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

7.4. Test Data

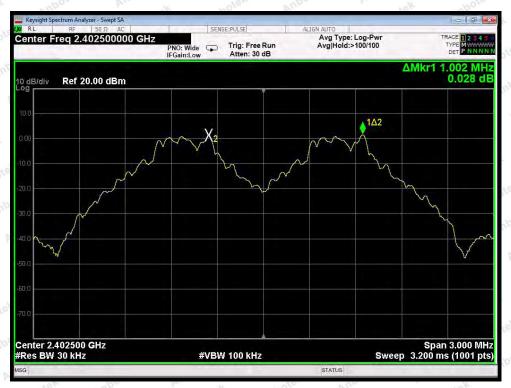
Test Item	:	Frequency Separation	Test Mode	:	CH Low ~ CH High
Test Voltage	:	AC 120V, 60Hz	Temperature	:	24℃
Test Result	:	PASS	Humidity	:	55%RH

Channel	Frequency	Separation Read	Limit	Modulation Mode	
Chamiei	(MHz)	Value (kHz)	(kHz)		
Low	2402	1000	928.0	BDR	
Middle	2441	1000	881.5	BDR	
High	2480	1000	929.7	BDR Mbot	
Low	2402	1000	974.0	Anbote EDR Anbo	
Middle	2441	1000	966.7	EDR	
High	2480	1000	986.7	EDR	

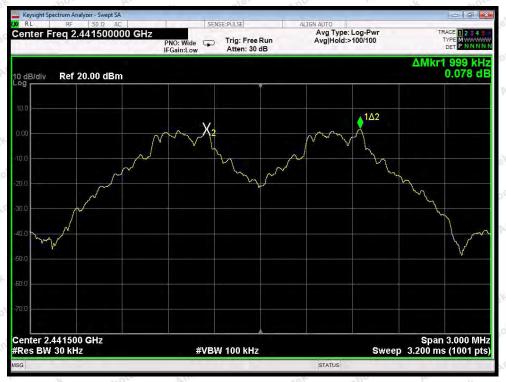
Remark:

- 1. The limit of mode (EDR) is 2/3 of 20dB BW;
- 2. The EDR was tested on (π /4DQPSK, 8DPSK) modes, only the worst data of (8DPSK) is attached in the following pages.

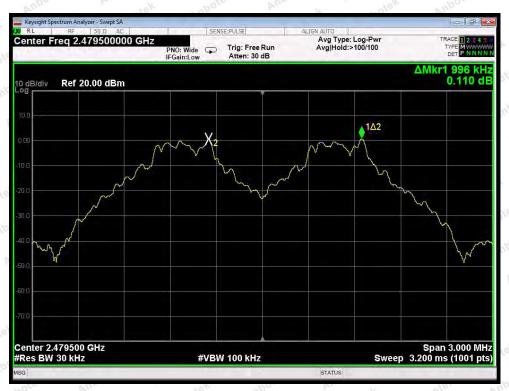




Test Mode: BDR---Low



Test Mode: BDR---Middle



Test Mode: BDR---High



Test Mode: EDR---Low



Test Mode: EDR---Middle



Test Mode: EDR---High

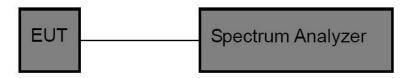


8. Number of Hopping Channel Test

8.1. Test Standard and Limit

Test Standard	FCC Part15 C	Section 15.2	247 (a)(1)	Am	Anbotek	Anbo	þ.
Test Limit	>15 channels	Anbotek	Anboro	An. botek	Anbotek	Anbo	1

8.2. Test Setup



8.3. Test Procedure

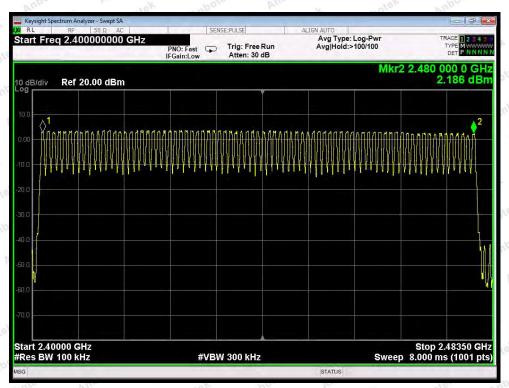
The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

- 1. Span= the frequency band of operation
- 2. Set the RBW = 100kHz.
- 3. Set the VBW = 300kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

8.4. Test Data

Test Item	: Number of Hopping Frequency	Test Mode	:	CH Low ~ CH High
Test Voltage	: AC 120V, 60Hz	Temperature	:	24℃
Test Result	: PASS	Humidity	:	55%RH

Hopping Channel Frequency Range	Quantity of Hopping Channel	Quantity of Hopping Channel	
2402-2480MHz	Amb 79 botek Ambo	>15	



BDR Mode



EDR Mode

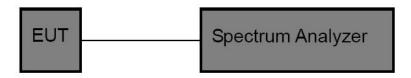


9. Dwell Time Test

9.1. Test Standard and Limit

Test Standard	FCC Part15	C Section 15.2	247 (a)(1)	Annabotek	Anbotek	Anbo.	p.
Test Limit	0.4 sec	Anbotek	Anboro	Air	Anbotek	Anbo	F .

9.2. Test Setup



9.3. Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

- 1. Span= zero span, centered on a hopping channel
- 2. Set the RBW = 1 MHz.
- 3. Set the VBW = 1 MHz.
- 4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

9.4. Test Data

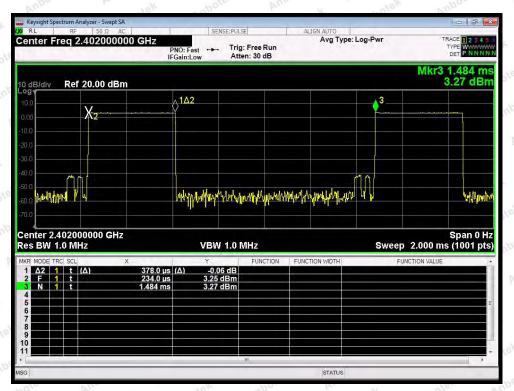
Test Item : Time of Occupancy Test Mode : CH Low ~ CH High

Test Voltage : AC 120V, 60Hz Temperature : 24° C Test Result : PASS Humidity : 55° RH

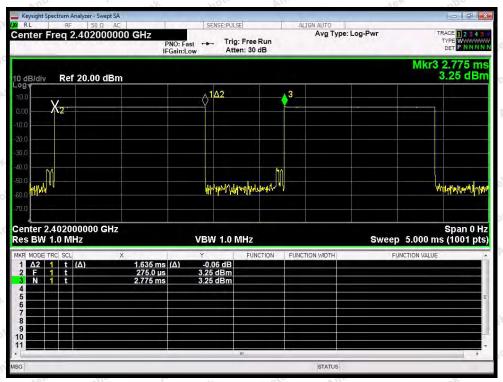
Package Type	Pulse width (ms)	Time slot length(ms)	Dwell time (ms)	Limit (s)	Modulation
DH1	0.378	time slot length *1600/2 /79 * 31.6	120.96	0.4	BDR
DH3	1.635	time slot length *1600/4 /79 * 31.6	261.60	0.4	BDR
DH5	2.880	time slot length *1600/6 /79 * 31.6	307.20	0.4	BDR
3DH1	0.386	time slot length *1600/2 /79 * 31.6	123.52	0.4	EDR
3DH3	1.640	time slot length *1600/4 /79 * 31.6	262.40	0.4	EDR
3DH5	2.896	time slot length *1600/6 /79 * 31.6	308.91	0.4	EDR

Remark: The EDR was tested on ($\pi/4$ DQPSK, 8DPSK) modes, only the worst data of (8DPSK) is attached in the following pages.

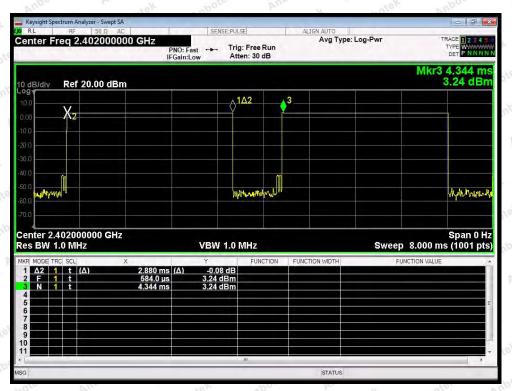




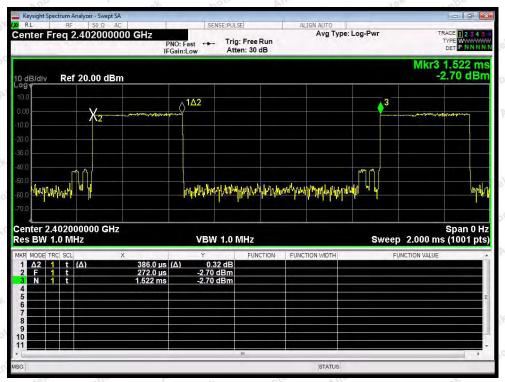
Test Mode: BDR---DH1



Test Mode: BDR---DH3

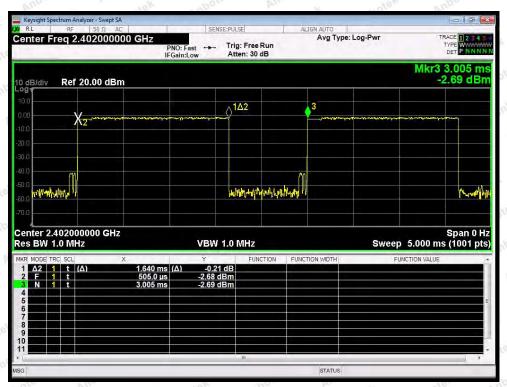


Test Mode: BDR—DH5

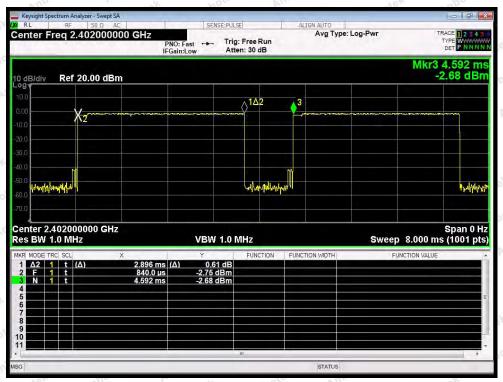


Test Mode: EDR---3DH1





Test Mode: EDR---3DH3



Test Mode: EDR—3DH5

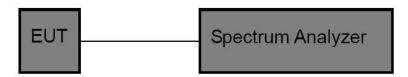


10. 100kHz Bandwidth of Frequency Band Edge Requirement

10.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (d)
Test Limit	in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator in operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a).

10.2. Test Setup



10.3. Test Procedure

The EUT must have its hopping/Non-hopping function enabled. Using the following spectrum analyzer setting:

- 1. Set the RBW = 100kHz.
- 2. Set the VBW = 300kHz.
- 3. Sweep time = auto couple.
- 4. Detector function = peak.
- 5. Trace mode = max hold.
- 6. Allow trace to fully stabilize.

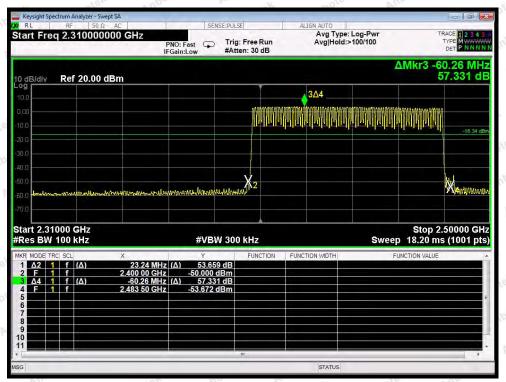
10.4. Test Data

Test Item : Band edge : CH Low \sim CH High Test Voltage : AC 120V, 60Hz : Temperature : 24 $^{\circ}$ C : Test Result : PASS : Humidity : 55 $^{\circ}$ RH

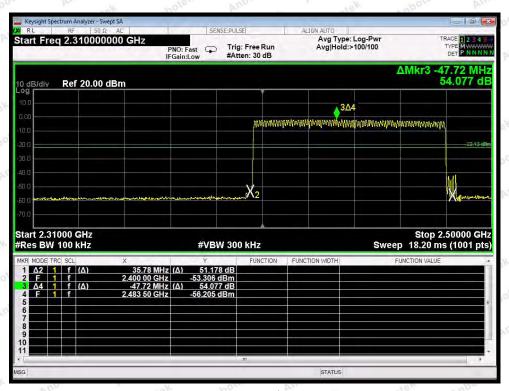
Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of $(\pi/4DQPSK)$ is attached in the following pages.



For Hopping Mode



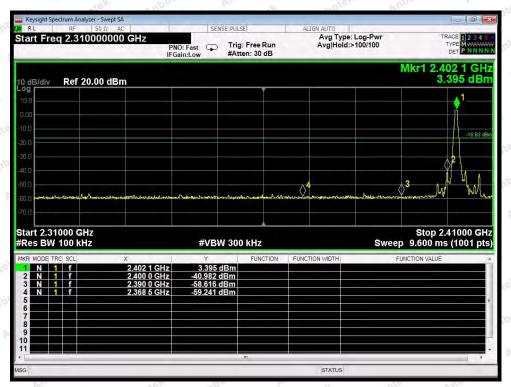
BDR mode



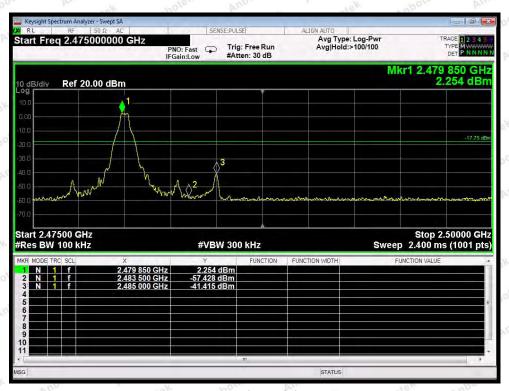
EDR mode



For Non-Hopping Mode



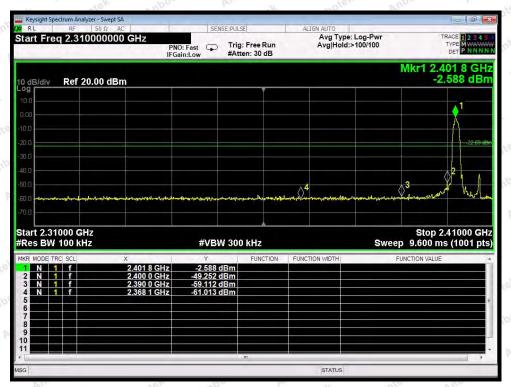
BDR mode -- Lowest



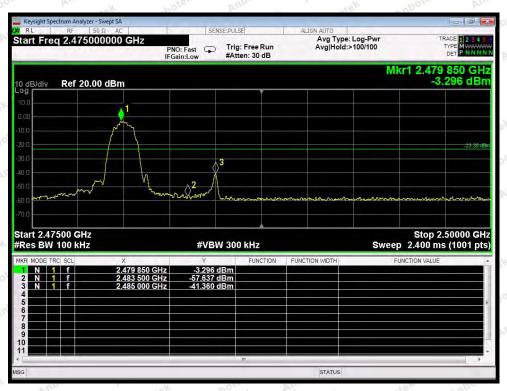
BDR mode -- Highest



For Non-Hopping Mode



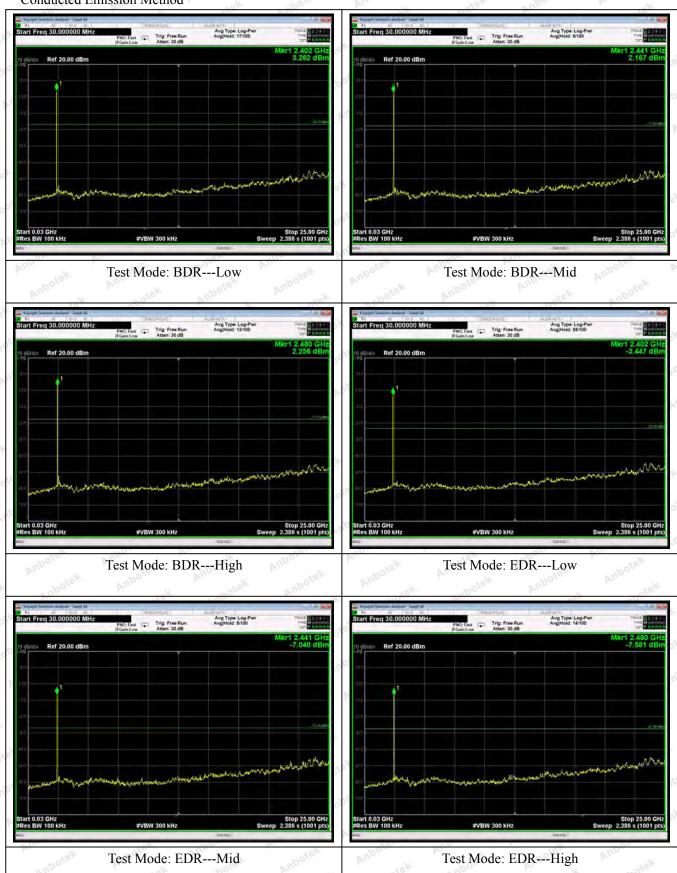
EDR mode -- Lowest



EDR mode -- Highest



Conducted Emission Method





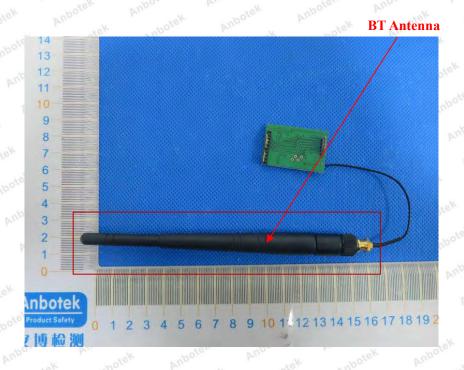
11. Antenna Requirement

11.1. Test Standard and Requirement

Test Standard	FCC Part15 Section 15.203 /247(c)
Requirement	1) 15.203 requirement: An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. 2) 15.247(c) (1)(i) requirement: Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed. Point-to-point operations may employ transmitting antennas with directional gain greater than 6dBi provided the maximum conducted output power of the intentional radiator is
	reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi.

11.2. Antenna Connected Construction

The bluetooth antenna is Cylindrical Antenna which permanently attached, and the best case gain of the antenna is 3 dBi. It complies with the standard requirement.



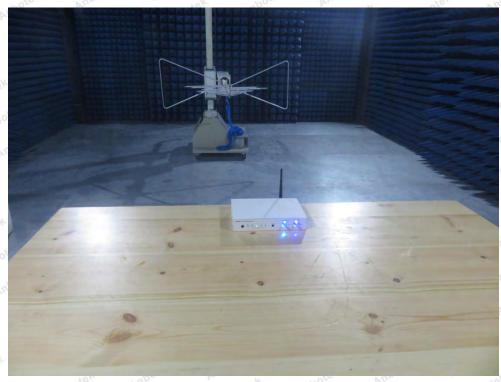


APPENDIX I -- TEST SETUP PHOTOGRAPH

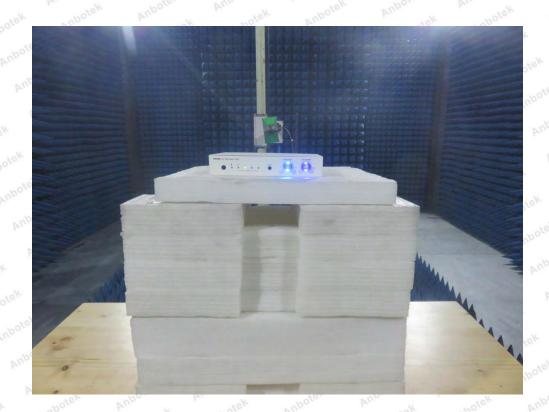




Photo of Radiation Emission Test



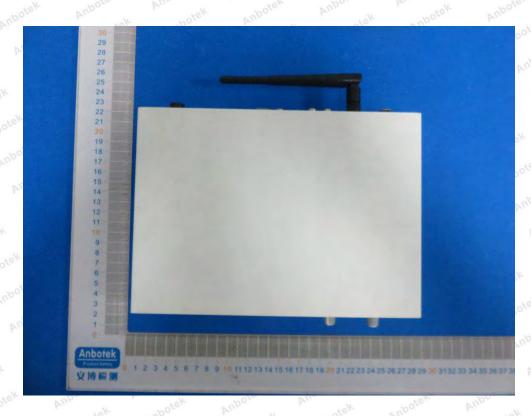




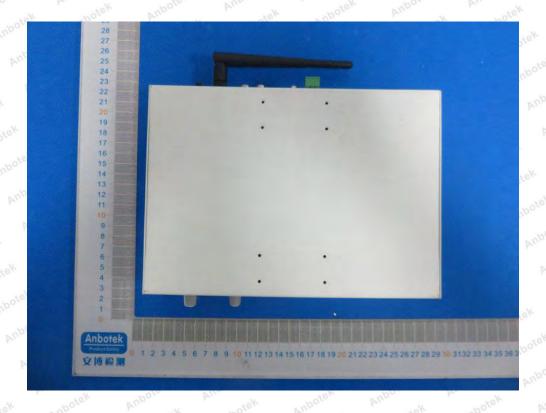


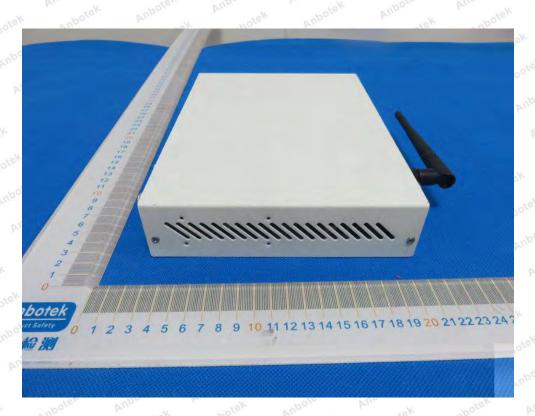
APPENDIX II -- EXTERNAL PHOTOGRAPH



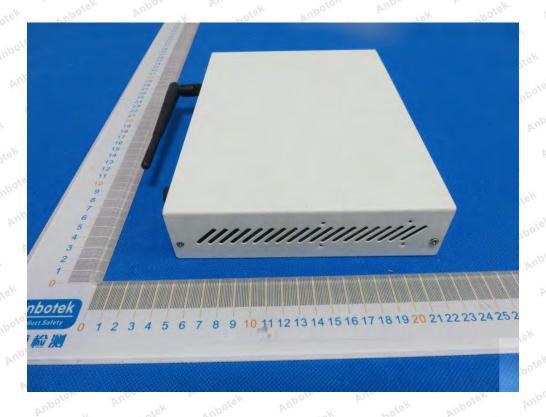


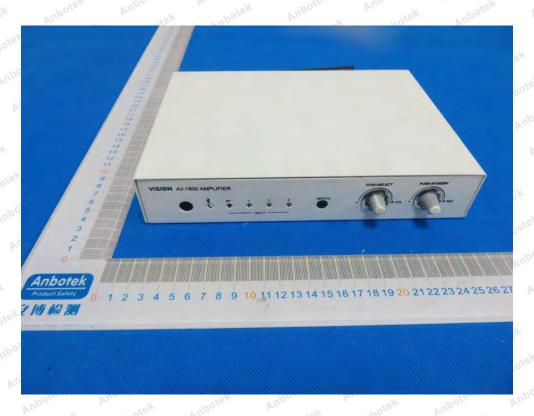




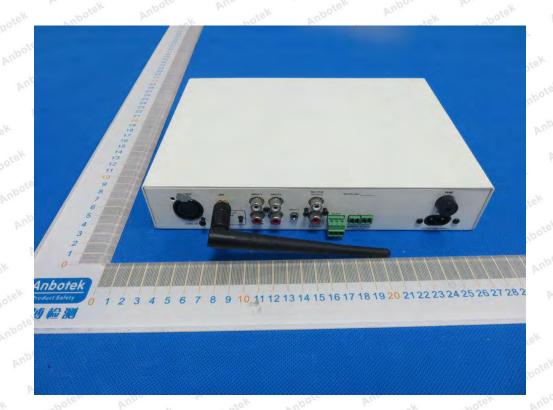












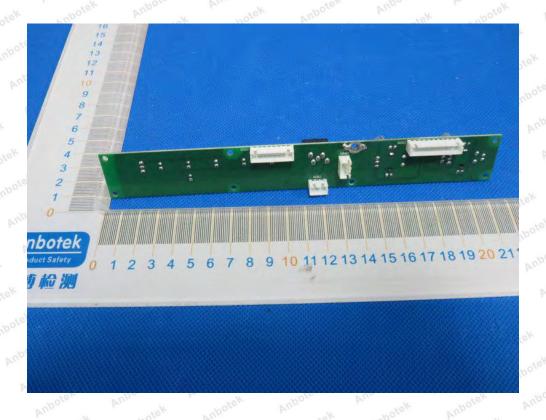


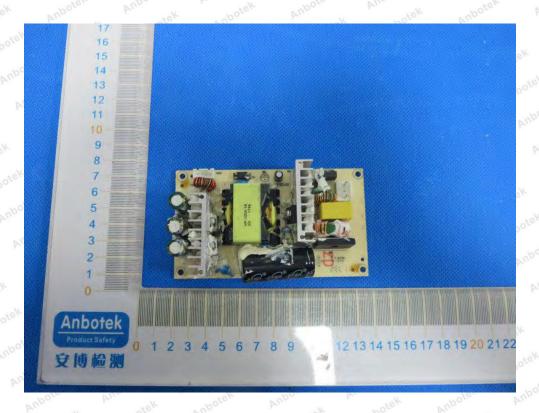
APPENDIX III -- INTERNAL PHOTOGRAPH



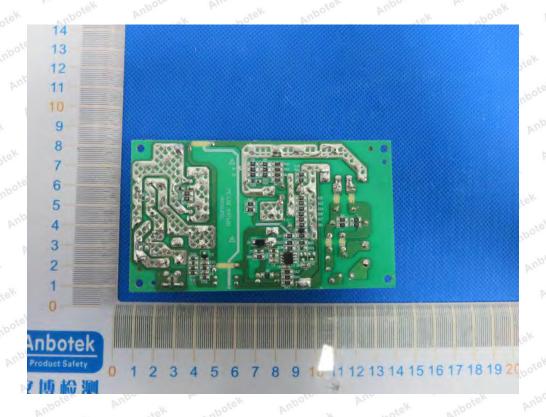






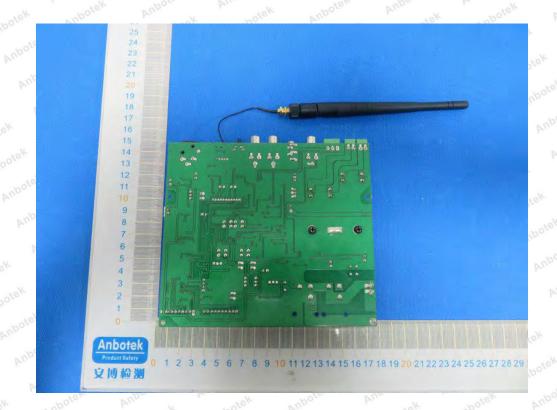


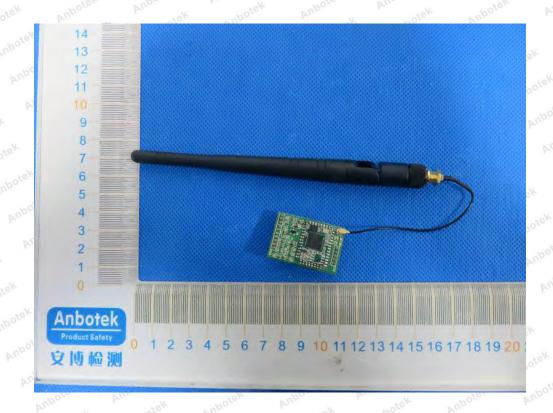






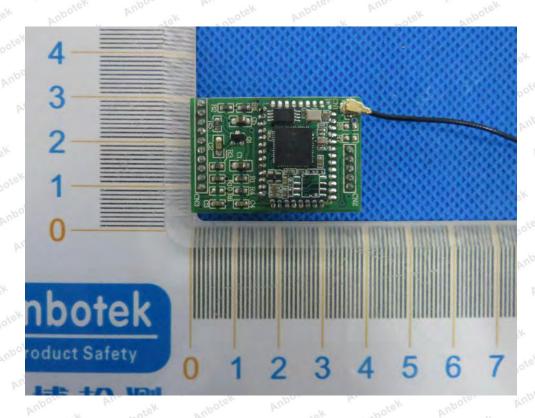




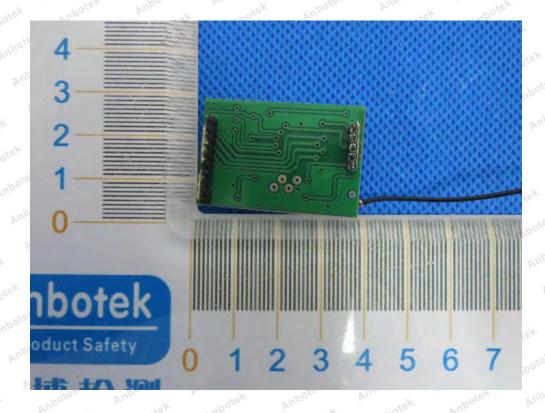


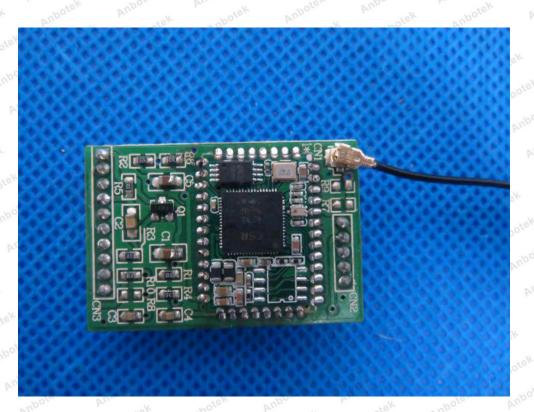




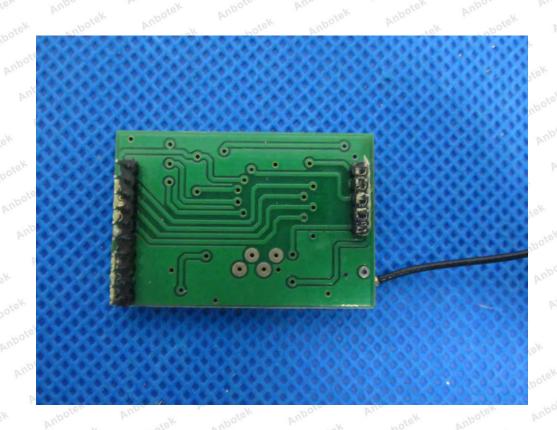












----- End of Report -----